

Application/Control	No.
10/579.929	

Applicant(s)/Patent under Reexamination

BOEVE, HANS MARC BERT

Art Unit

2824

Examiner Hien N. Nguyen

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ORIGINAL					INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS						CL	AIMED	ИОИ	NON-CLAIMED					
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HIEN NGUYEN 1/20/08
(Assistant Examiner) (Date)

(Legal instruments Examiner) (Date)

SON DINH

RIMARY PATENT EXAMINER
(Primary Examiner) (Date)
// 22/08

**Total Claims Allowed: 8** 

O.G. Print Claim(s)

O.G. Print Fig.

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	Claims renumbered in the same order as presented by applicant [								ΩС	PA	☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original	Final	Original		Final	Original
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1	0			32			62			92			122		152			182
2	3			33			63	]		93			123		153			183
3	4			34			64			94			124		154			184
4	5			35			65			95			125		155			185
5	6			36			66			96			126		156			186
6	7			37			67	]		97			127		157			187
7	8			38			68	]		98			128		158			188
8	9			39			69			99			129		159			189
	10			40			70			100			130		160			190
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	13			43			73			103			133		163			193
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	23			53			83			113			143		173			203
	24			54			84			114			144		174			204
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	26			56			86			116			146		176			206
	27			_57			87			117			147		177			207
	28			58			88			118			148		178			208
	29			59			89			119			149		179			209
	30			60			90			120			150		180			210